Se	arcn Notes

s	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/040,605	DAVID HARRIMAN ET AL.
	Examiner	Art Unit
	Azizul Choudhury	2145

SEARCHED				
Class	Subclass	Date	Examiner	
	7.00			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (View Search History)	12/26/2005	AC
ACM, IEEE, INSPEC (Searched TLP, transaction layer packet, type field, format field, etc.)	12/23/2005	AC
Citeseer (Searched TLP, transaction layer packet, type field, format field, etc.)	12/23/2005	AC
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